

<b>Notice of References Cited</b>	Application/Control No. 10/840,206	Applicant(s)/Patent Under Reexamination CHESAL ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0163072	08-2004	Levy, Yinon	717/106
*	B	US-2005/0114818	05-2005	Khakzadi et al.	716/011
*	C	US-7,024,661	04-2006	Leino et al.	717/126
*	D	US-6,536,017	03-2003	Sanders, Lester S.	716/3
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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